MOSFET - Power, Dual N-Channel, DUAL SO8FL

60 V, 20.3 mΩ, 27 A

NTMFD020N06C

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Typical Applications

- Power Tools, Battery Operated Vacuums
- UAV/Drones, Material Handling
- BMS/Storage, Home Automation

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter			Symbol	Value	Units
Drain-to-Source Voltage			V _{DSS}	60	V
Gate-to-Source Voltage			V _{GS}	±20	V
Continuous Drain	Steady State	T _C = 25°C	I _D	27	Α
Current R _{θJC} (Notes 1, 3)	State	T _C = 100°C		19	
Power Dissipation	Steady	T _C = 25°C	P_{D}	31	W
R _{θJC} (Note 1)	State	T _C = 100°C		15	
Continuous Drain Current R _{0JA}	Steady T _A = 25°C		I _D	8	Α
(Notes 1, 2, 3)	State	T _A = 100°C		6	
Power Dissipation	Steady T _A = 25°C		P _D	3.1	W
R _{θJA} (Notes 1, 2)	State	T _A = 100°C		1.5	
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I _{DM}	98	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			Is	25	Α
Single Pulse Drain-to-Source Avalanche Energy ($I_L = 5.7 A_{pk}$)			E _{AS}	16	mJ
Lead Temperature Soldering Reflow for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

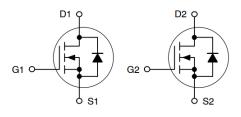


ON Semiconductor®

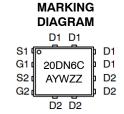
www.onsemi.com

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
60 V	20.3 mΩ @ 10 V	27 A

Dual N-Channel







20DN6C = Specific Device Code

= Assembly Location

= Year W = Work Week = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFD020N06CT1G	SO8FL Dual (Pb-Free)	1500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Case - Steady State (Note 2)	$R_{ heta JC}$	4.8	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	47	C/VV

ELECTRICAL CHARACTERISTICS (T_{.1} = 25°C unless otherwise specified)

Parameter	Symbol	Test Co	ondition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	1			•			11
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	I _D = 250 μA	, ref to 25°C		29		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 \text{ V}, \qquad T_{J} = 25^{\circ}\text{C}$				10	μΑ
	V _{DS} = 60 V T _J = 125°C			250	1		
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V,	V _{GS} = 20 V			100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, I _D = 20 μA	2.0		4.0	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} / T _J	$I_D = 20 \mu A$,	ref to 25°C		-7.8		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 \	V, I _D = 4 A		16.9	20.3	mΩ
Forward Transconductance	9FS	V _{DS} = 5 \	/, I _D = 4 A		12		S
Gate Resistance	R_{G}	T _A = 25°C			1.0		Ω
CHARGES & CAPACITANCES							
Input Capacitance	C _{ISS}				355		pF
Output Capacitance	C _{OSS}	V_{GS} = 0 V, f = 1 MHz, V_{DS} = 30 V			260		
Reverse Capacitance	C _{RSS}				4.9		
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 10 V, V_{DS} = 30 V, I_D = 4 A			5.8		nC
Threshold Gate Charge	Q _{G(TH)}				1.4		
Gate-to-Source Charge	Q_{GS}				2.3		
Gate-to-Drain Charge	Q_{GD}				0.53		
SWITCHING CHARACTERISTICS (Note	e 3)			•	•		
Turn-On Delay Time	t _{d(ON)}				6.5		ns
Rise Time	t _r	V _{GS} = 10 V.	Vne = 30 V.		1.4		
Turn-Off Delay Time	t _{d(OFF)}	V_{GS} = 10 V, V_{DS} = 30 V, I_D = 4 A, R_G = 6 Ω			9.7		
Fall Time	t _f				4.0		
DRAIN-SOURCE DIODE CHARACTER	RISTICS			•	•	•	*
	V _{SD}	V _{GS} = 0 V, I _S = 4 A	T _J = 25°C		0.81	1.2	V
Forward Voltage			T _J = 125°C		0.67		
Reverse Recovery Time	t _{RR}	V_{GS} = 0 V, d_{IS}/d_t = 100 A/ μ s, I_S = 4 A			24		ns
Charge Time	ta				12		
Discharge Time	tb				12		
Reverse Recovery Charge	Q _{RR}				12		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS

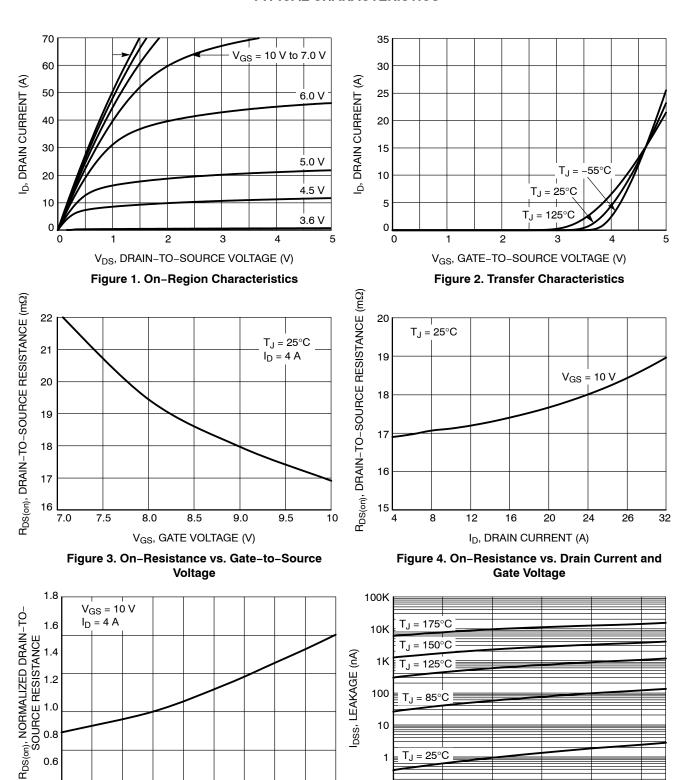


Figure 5. On-Resistance Variation with **Temperature**

T_J, JUNCTION TEMPERATURE (°C)

50

75

100

125

1.0

8.0

0.6 0.4

-50

-25

0

25

Figure 6. Drain-to-Source Leakage Current vs. Voltage

V_{DS}, DRAIN-TO-SOURCE VOLTAGE (V)

35

45

55

25

150

10

1

0.1

 $T_J = 25^{\circ}C$

15

TYPICAL CHARACTERISTICS

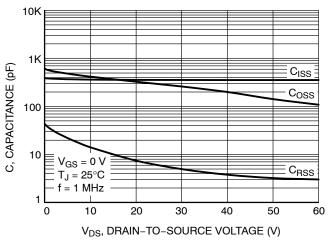


Figure 7. Capacitance Variation

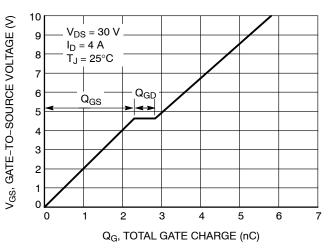


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

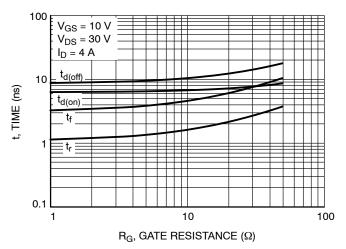


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

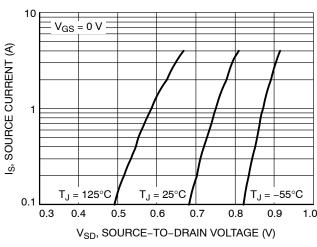


Figure 10. Diode Forward Voltage vs. Current

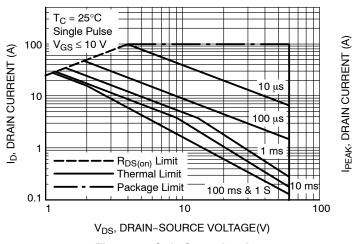


Figure 11. Safe Operating Area

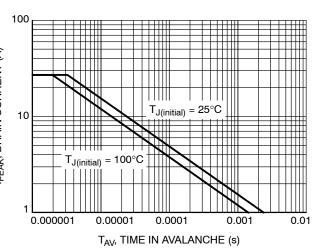


Figure 12. I_{PEAK} vs. Time in Avalanche

TYPICAL CHARACTERISTICS

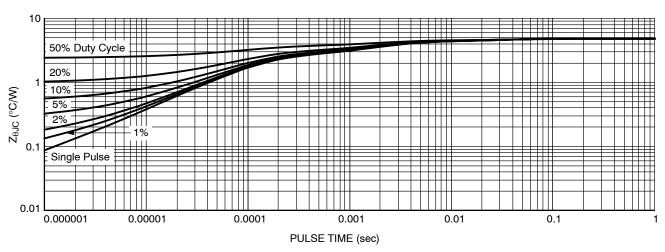
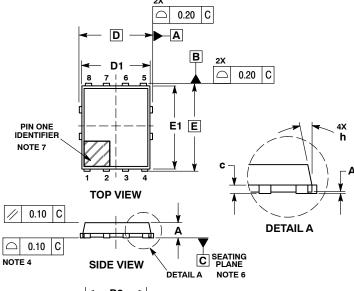


Figure 13. Thermal Response

PACKAGE DIMENSIONS

DFN8 5x6, 1.27P Dual Flag (SO8FL-Dual)

CASE 506BT **ISSUE E**

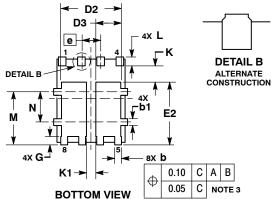


NOTES:

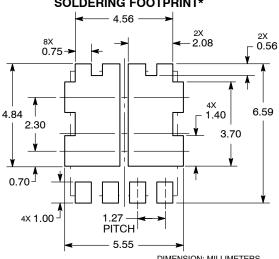
- NOTES:

 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 2. CONTROLLING DIMENSION: MILLIMETERS.
 3. DIMENSION & APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30 MM FROM THE TERMINAL TIP.
 4. PROFILE TOLERANCE APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.
 5. DIMENSIONS DI AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
 6. SEATING PLANE IS DEFINED BY THE TERMINALS. A1 IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST. AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.
 A VISUAL INDICATOR FOR PIN 1 MUST BE LOCATED IN THIS AREA.

	MILLIMETERS			
DIM	MIN	MAX	MAX	
Α	0.90	-	1.10	
A1		-	0.05	
b	0.33	0.42	0.51	
b1	0.33	0.42	0.51	
С	0.20		0.33	
D		5.15 BSC		
D1	4.70	4.90	5.10	
D2	3.90	4.10	4.30	
D3	1.50	1.70	1.90	
E	6.15 BSC			
E1	5.70	5.90	6.10	
E2	3.90	4.15	4.40	
е	1.27 BSC			
G	0.45	0.55	0.65	
h			12 °	
K	0.51			
K1	0.56			
L	0.48	0.61	0.71	
М	3.25	3.50	3.75	
N	1.80	2.00	2.20	



SOLDERING FOOTPRINT*



DIMENSION: MILLIMETERS

^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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